Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/517,445	NISHII ET AL.	
Examiner	Art Unit	
Donahai D. Mauyan	2720	

SEARCHED					
Class	Subclass	Date	Examiner		
29	825, 829 830, 831 846, 848 851	3/27/2007	DN		
156	102, 228	[1		
	230, 233				
	582				
	583.1				
174	. 262				
216	20	1			
428	96	J	V		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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East Search Updated (see attached)	3/27/2007	ov)